Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/531,930	DE WIT ET AL.	
Examiner	Art Unit	
Tuan H. Nauven	2618	

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SEARCHED							
Class	Subclass	Date	Examiner				
455	66.1,425	2/13/2008	T.N				
455	426.1	2/13/2008	T.N				
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INI	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
All searches are on EAST data base.	2/13/2008	T.N		
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